

RoHS Compliant Product
A suffix of "-C" specifies halogen free

DESCRIPTION

The SSU56N45S-C is the highest performance trench N-Ch MOSFETs with extreme high cell density, which provide excellent $R_{DS(ON)}$ and gate charge for most of the synchronous buck converter applications .

The SSU56N45S-C meet the RoHS and Green Product requirement with full function reliability approved.

FEATURES

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent dv/dt effect decline
- Green Device Available

MARKING



PACKAGE INFORMATION

Package	MPQ	Leader Size
TO-263	0.8K	13 inch

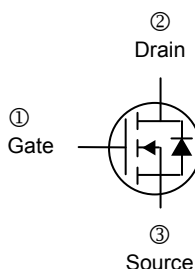
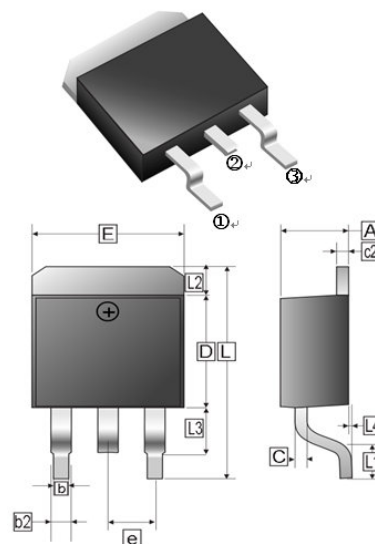
ORDER INFORMATION

Part Number	Type
SSU56N45S-C	Lead (Pb)-free and Halogen-free

ABSOLUTE MAXIMUM RATINGS (T_A=25°C unless otherwise specified)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V _{DS}	45	V
Gate-Source Voltage	V _{GS}	±20	V
Continuous Drain Current ¹ @V _{GS} =10V	I _D	T _C =25°C	56
		T _C =100°C	36
Pulsed Drain Current ²	I _{DM}	150	A
Power Dissipation	P _D	52	W
Operating Junction and Storage Temperature	T _J , T _{STG}	-55~150	°C
Thermal Resistance Rating			
Thermal Resistance Junction-Ambient ¹	R _{θJA}	50	°C / W
Thermal Resistance Junction-Case ¹	R _{θJC}	2.4	°C / W

TO-263



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	4.00	4.87	c2	1.07	1.65
b	0.51	1.01	b2	1.34	REF
L4	0.00	0.30	D	8.0	9.65
C	0.30	0.74	e	2.54	REF
L3	1.50	REF	L	14.6	16.1
L1	2.5	REF	L2	1.27	REF
E	9.60	10.67			

ELECTRICAL CHARACTERISTICS ($T_J=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	45	-	-	V	$V_{GS}=0V, I_D=250\mu A$
Gate-Threshold Voltage	$V_{GS(th)}$	1	-	2.2	V	$V_{DS}=V_{GS}, I_D=250\mu A$
Forward Transconductance	g_{fs}	-	25	-	S	$V_{DS}=5V, I_D=20A$
Gate-Source Leakage Current	I_{GSS}	-	-	± 100	nA	$V_{GS}=\pm 20V, V_{DS}=0V$
Drain-Source Leakage Current	I_{DSS}	-	-	1	μA	$V_{DS}=36V, V_{GS}=0V, T_J=25^\circ\text{C}$
		-	-	100		$V_{DS}=36V, V_{GS}=0V, T_J=100^\circ\text{C}$
Static Drain-Source On-Resistance ³	$R_{DS(ON)}$	-	7.6	9.5	m Ω	$V_{GS}=10V, I_D=20A$
		-	10.7	14		$V_{GS}=4.5V, I_D=10A$
Gate Resistance	R_g	-	1.5	-	Ω	$V_{DS}=V_{GS}=0V, f=1\text{MHz}$
Total Gate Charge (4.5V)	Q_g	-	7	-	nC	$I_D=10A$ $V_{DD}=20V$ $V_{GS}=10V$
Total Gate Charge	Q_g	-	14.5	-		
Gate-Source Charge	Q_{gs}	-	2	-		
Gate-Drain Change	Q_{gd}	-	2.5	-		
Turn-on Delay Time	$T_{d(on)}$	-	6	-	nS	$V_{DD}=20V$ $I_D=10A$ $V_{GS}=10V$ $R_G=10\Omega$
Rise Time	T_r	-	5	-		
Turn-off Delay Time	$T_{d(off)}$	-	21	-		
Fall Time	T_f	-	5	-		
Input Capacitance	C_{iss}	-	942	-	pF	$V_{GS}=0V$ $V_{DS}=20V$ $f=1\text{MHz}$
Output Capacitance	C_{oss}	-	309	-		
Reverse Transfer Capacitance	C_{rss}	-	29	-		
Source-Drain Diode						
Diode Forward Voltage ³	V_{SD}	-	-	1.2	V	$I_F=20A, V_{GS}=0V$
Reverse Recovery Time	T_{rr}	-	24	-	ns	$I_F=10A, V_R=20V, dI_F/dt=200A/\mu s$
Reverse Recovery Charge	Q_{rr}	-	19	-	nC	

Notes:

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
2. The Pulse width limited by maximum junction temperature, Pulse Width $\leq 300\mu s$, Duty Cycles $\leq 2\%$
3. The Pulse Test : Pulse Width $\leq 300\mu s$, Duty Cycles $\leq 2\%$

CHARACTERISTIC CURVES

Fig 1. Typical Output Characteristics

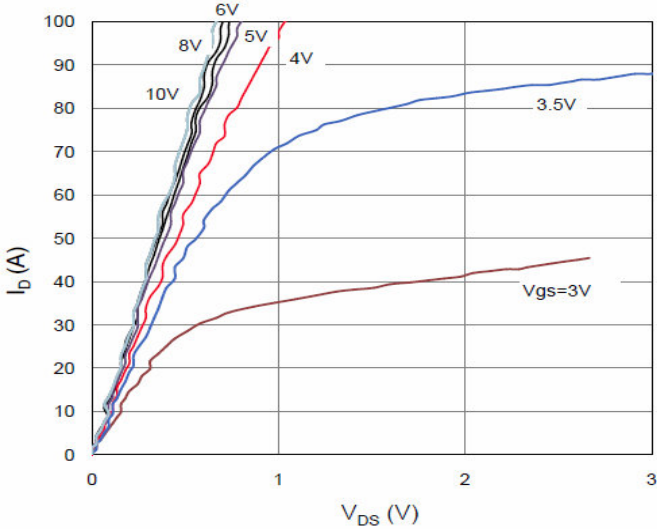


Figure 2. On-Resistance vs. Gate-Source Voltage

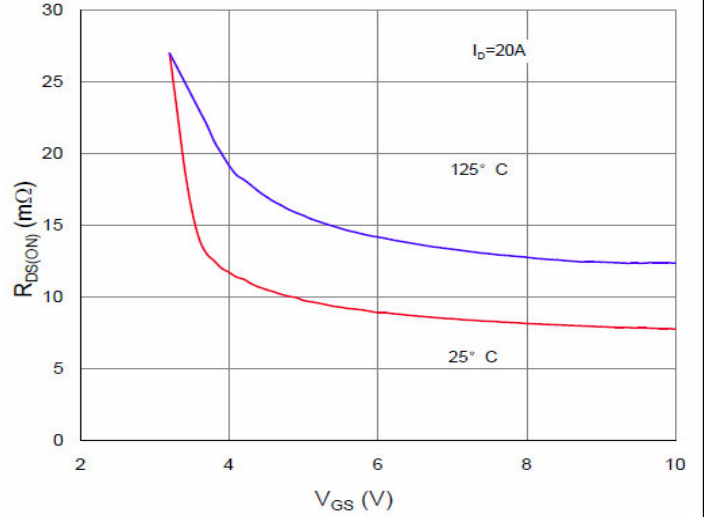


Figure 3. On-Resistance vs. Drain Current and Gate Voltage

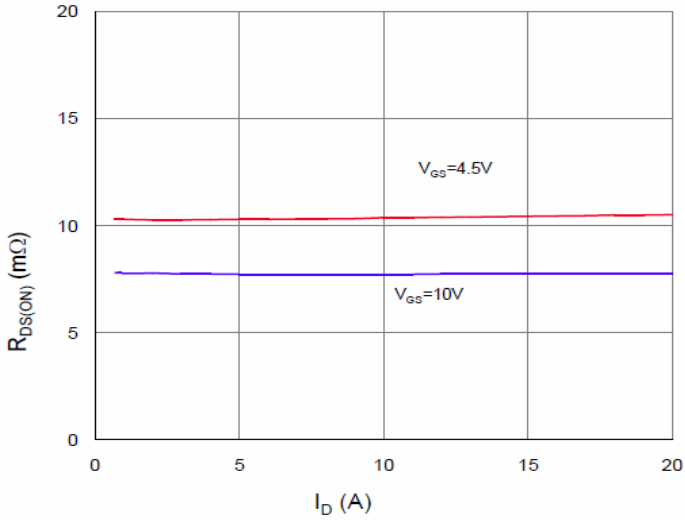


Figure 4. Normalized On-Resistance vs. Junction Temperature

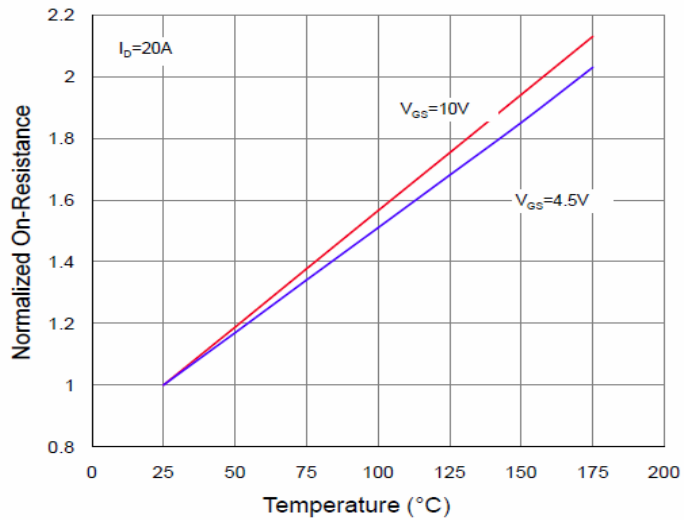


Figure 5. Typical Transfer Characteristics

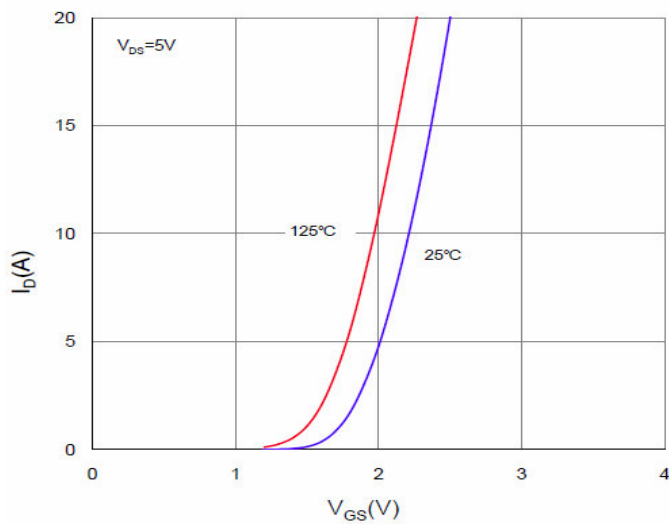
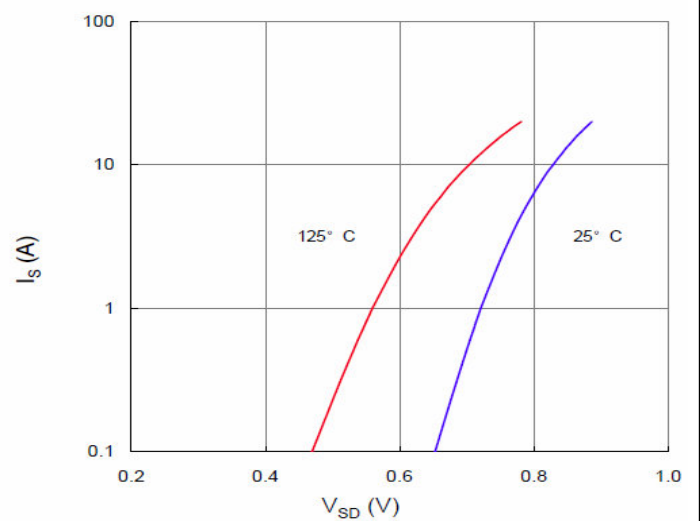


Figure 6. Typical Source-Drain Diode Forward Voltage



CHARACTERISTIC CURVES

Figure 7. Typical Gate-Charge vs. Gate-to-Source Voltage

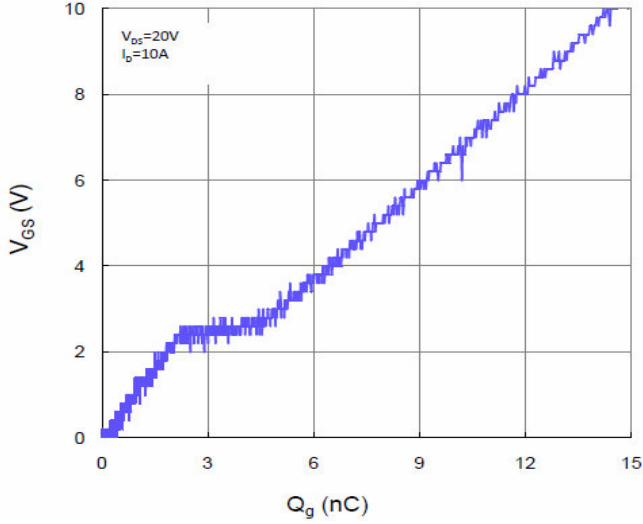


Figure 8. Typical Capacitance vs. Drain-to-Source Voltage

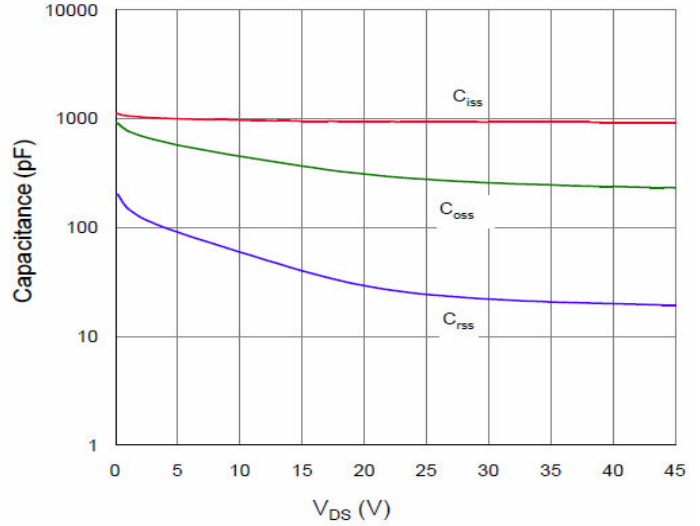


Figure 9. Maximum Safe Operating Area

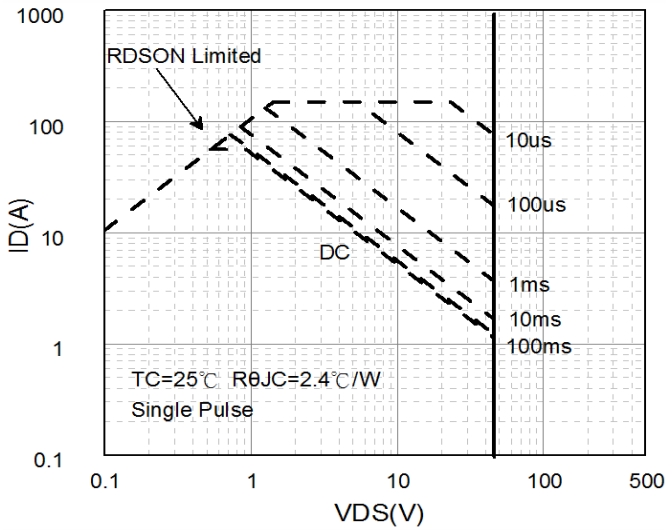


Figure 10. Drain Current vs. Case Temperature

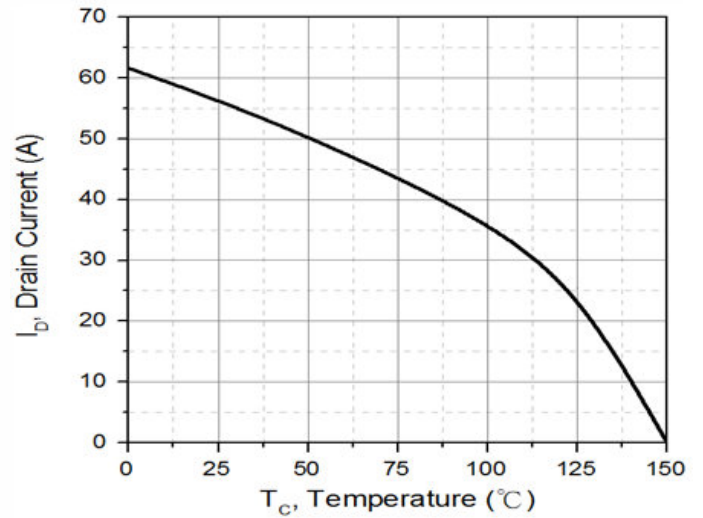


Figure 11. Normalized Maximum Transient Thermal Impedance, Junction-to-Case

